### Features

- Advanced Process Technology •
- **Dual N-Channel MOSFET**

International

**ICR** Rectifier

- Ultra Low On-Resistance
- 175°C Operating Temperature •
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax •
- Lead-Free, RoHS Compliant •
- Automotive Qualified \*

#### Description

Specifically designed for Automotive applications, this HEXFET<sup>®</sup> Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this product an extremely efficient and reliable device for use in Automotive and wide variety of other applications.

#### **Applications**

- 12V Automotive Systems
- Low Power Brushed Motor
- Braking

Base Part Number	Package Type	Standard	Orderable Part Number	
		Form	Quantity	
AUIRFN8458	Dual PQFN 5mm x 6mm	Tape and Reel	4000	AUIRFN8458TR

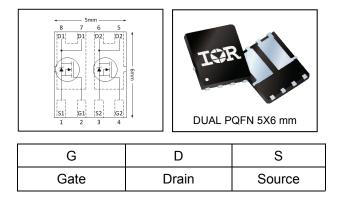
#### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolutemaximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C (Bottom)</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	43	
$I_D @ T_{C (Bottom)} = 100^{\circ}C$ Continuous Drain Current, $V_{GS} @ 10V$		30	А
I <sub>DM</sub>	Pulsed Drain Current ①	180	
P <sub>D</sub> @T <sub>C (Bottom)</sub> = 25°C	Power Dissipation	34	W
	Linear Derating Factor	0.23	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 2	35	mJ
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy	37	
I <sub>AR</sub>	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	А
E <sub>AR</sub>	Repetitive Avalanche Energy ①		
TJ	Operating Junction and	-55 to + 175	Э°
T <sub>STG</sub>	Storage Temperature Range		C

HEXFET® is a registered trademark of International Rectifier. \*Qualification standards can be found at http://www.irf.com/

V <sub>DSS</sub>	40V		
R <sub>DS(on)</sub> typ.	8.0mΩ		
max	10mΩ		
I <sub>D</sub> (@T <sub>C (Bottom)</sub> = 25°C	43A		





### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
R <sub>eJC</sub> (Bottom)	Junction-to-Case ®		4.4	
R <sub>θJC</sub> (Top)	Junction-to-Case ®		50	°C // //
$R_{ ext{ heta}JA}$	Junction-to-Ambient ⑦		105	°C/W
R <sub>0JA</sub> (<10s)	Junction-to-Ambient 🗇		82	1

### Static Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	40			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		37		mV/°C	Reference to 25°C, $I_D$ = 1.0mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		8.0	10	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 26A
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.2		3.9	V	$V_{DS} = V_{GS}, I_D = 25 \mu A$
gfs	Forward Transconductance	56			S	V <sub>DS</sub> = 10V, I <sub>D</sub> = 26A
R <sub>G</sub>	Internal Gate Resistance		1.9		Ω	
1	Durin to Course Lookana Current			1.0		V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			150	μA	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	<b>n</b> A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Qg	Total Gate Charge		22	33		I <sub>D</sub> = 26A
Q <sub>gs</sub>	Gate-to-Source Charge		6.3			V <sub>DS</sub> = 20V
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		7.6		nC	V <sub>GS</sub> = 10V
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		14.4			I <sub>D</sub> = 26A, V <sub>DS</sub> =0V, V <sub>GS</sub> = 10V
t <sub>d(on)</sub>	Turn-On Delay Time		9.7			V <sub>DD</sub> = 26V
t <sub>r</sub>	Rise Time		71			I <sub>D</sub> = 26A
t <sub>d(off)</sub>	Turn-Off Delay Time		11		ns	$R_{G} = 2.7\Omega$
t <sub>f</sub>	Fall Time		19			V <sub>GS</sub> = 10V ④
C <sub>iss</sub>	Input Capacitance		1060			V <sub>GS</sub> = 0V
C <sub>oss</sub>	Output Capacitance		170			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		100		pF	f = 1.0 MHz
Coss eff. (ER)	Effective Output Capacitance (Energy Related)		210			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V \text{ (6)}$
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)		250			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $
Diode Characteristics						

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			43	^	MOSFET symbol
I <sub>S</sub>	(Body Diode)				A	showing the
1	Pulsed Source Current			180	^	integral reverse
I <sub>SM</sub>	(Body Diode) ①				A	p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 26A, V_{GS} = 0V$ (4)
dv/dt	Peak Diode Recovery		8.2		V/ns	$T_J$ = 175°C, $I_S$ = 26A, $V_{DS}$ = 40V3
+	Roverse Recovery Time		18		20	$T_J = 25^{\circ}C$
t <sub>rr</sub>	Reverse Recovery Time		19		ns	$T_{\rm J} = 125^{\circ}{\rm C}$ V <sub>R</sub> = 34V,
0	Boyeroo Boooyery Charge		9.6		20	$T_{\rm J} = 25^{\circ}{\rm C}$ $I_{\rm F} = 26{\rm A}$
Q <sub>rr</sub>	Reverse Recovery Charge		11		nC	
I <sub>RRM</sub>	Reverse Recovery Current		0.89		А	$T_J = 25^{\circ}C$



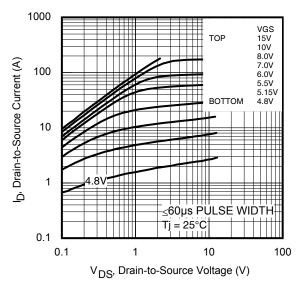


Fig. 1 Typical Output Characteristics

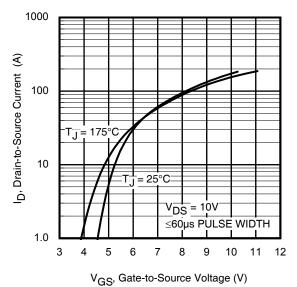


Fig. 3 Typical Transfer Characteristics

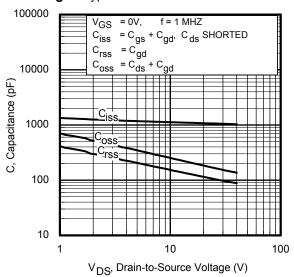


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

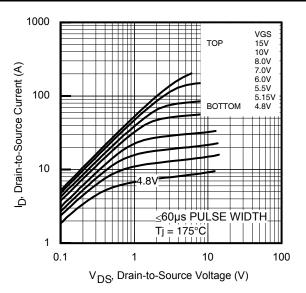
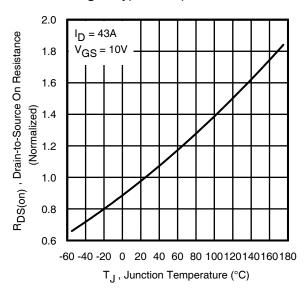


Fig. 2 Typical Output Characteristics





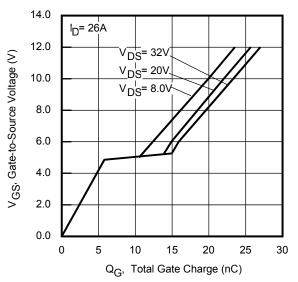
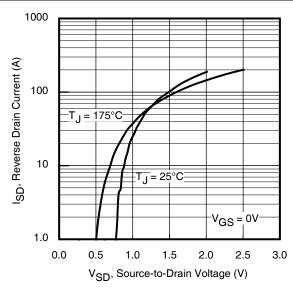
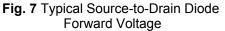


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage







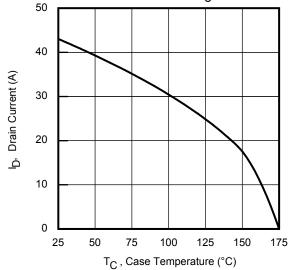


Fig 9. Maximum Drain Current vs. Case Temperature

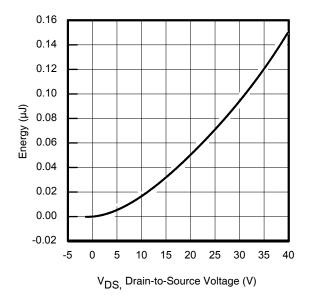


Fig 11. Typical Coss Stored Energy

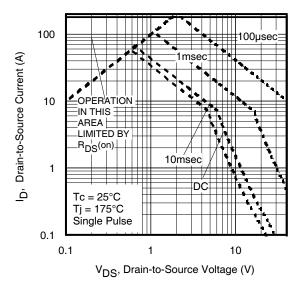


Fig 8. Maximum Safe Operating Area

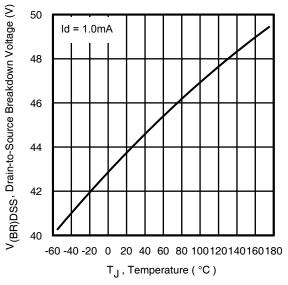


Fig 10. Drain-to-Source Breakdown Voltage

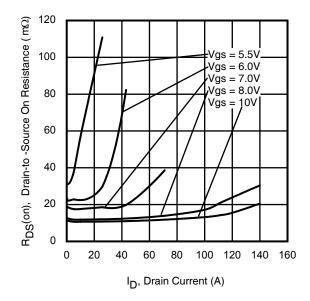
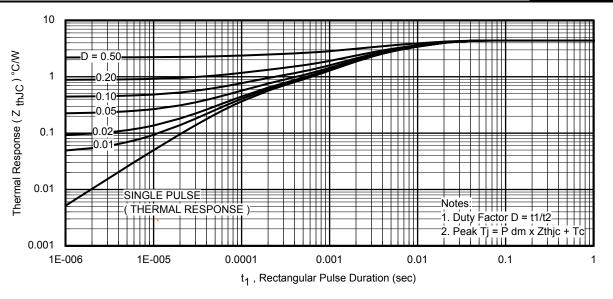
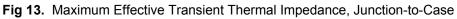


Fig 12. Typical On-Resistance vs. Drain Current

4







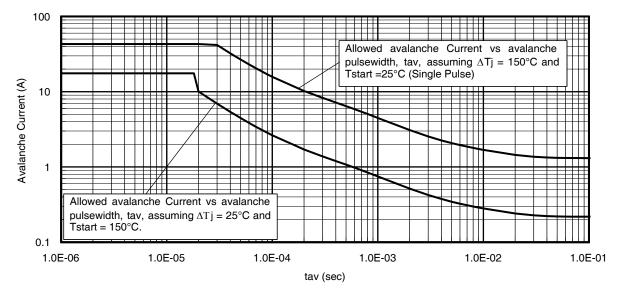


Fig 14. Typical Avalanche Current vs. Pulse Width

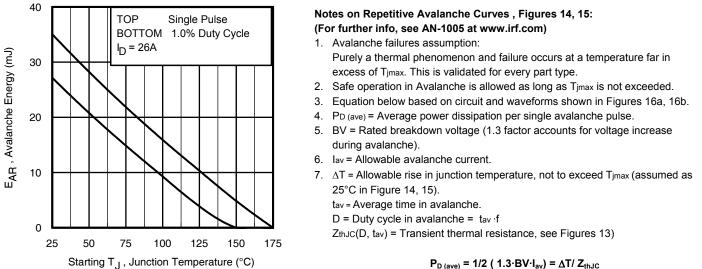


Fig 15. Maximum Avalanche Energy vs. Temperature

$$\begin{split} P_{D (ave)} &= 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJu} \\ I_{av} &= 2\Delta T / [1.3 \cdot BV \cdot Z_{th}] \\ &= E_{AS (AR)} = P_{D (ave)} \cdot t_{av} \end{split}$$



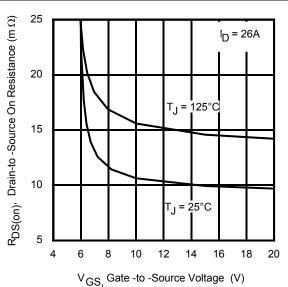


Fig 16. Typical On-Resistance vs. Gate Voltage

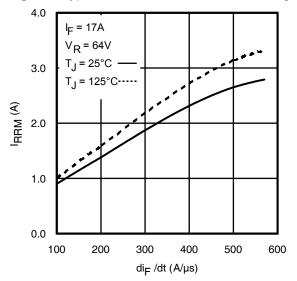


Fig. 18 - Typical Recovery Current vs. dif/dt

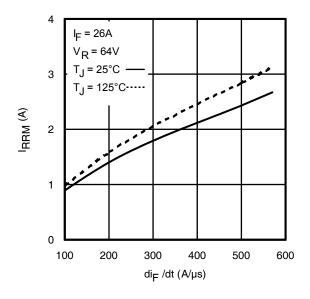


Fig. 20 - Typical Recovery Current vs. dif/dt

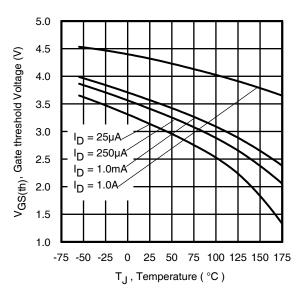


Fig 17. Threshold Voltage vs. Temperature

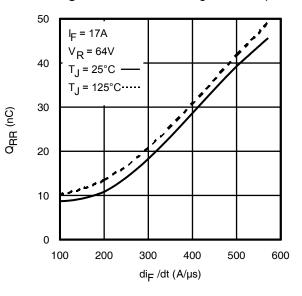


Fig. 19 - Typical Stored Charge vs. dif/dt

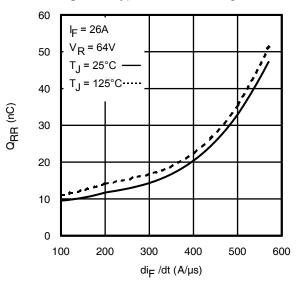
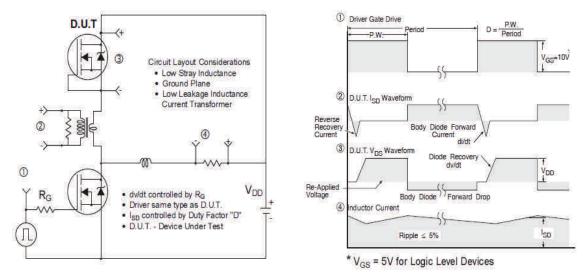
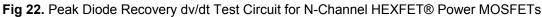


Fig. 21 - Typical Stored Charge vs. dif/dt

6





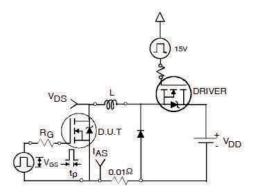


Fig 22a. Unclamped Inductive Test Circuit

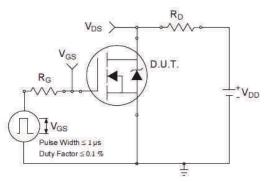


Fig 23a. Switching Time Test Circuit

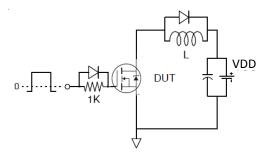


Fig 24a. Gate Charge Test Circuit

www.irf.com © 2014 International Rectifier

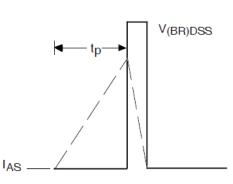


Fig 22b. Unclamped Inductive Waveforms

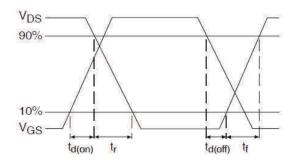
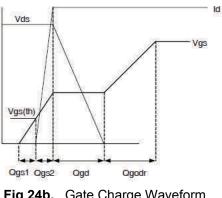
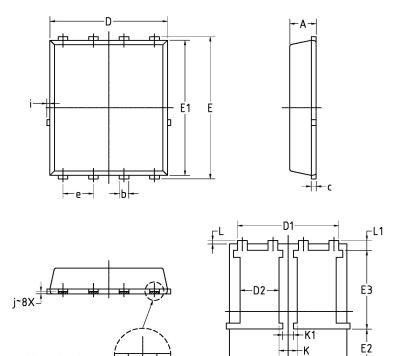


Fig 23b. Switching Time Waveforms





### Dual PQFN 5x6 Package Details



S Y	COMMON				
M B	ММ		INCH		
0 L	MIN.	MAX.	MIN.	MAX.	
Α	1.00	1.20	0.039	0.047	
b	0.30	0.50	0.012	0.020	
С	0.203	BSC	0.008	BSC	
D	4.80	5.00	0.189	0.197	
D1	4.06	4.36	0.160	0.172	
D2	1.47	1.77	0.058	0.070	
E	5.90	6.20	0.232	0.244	
E1	5.65	5.85	0.222	0.230	
E2	1.45	_	0.057		
E3	3.20	3.50	0.126	0.138	
e	1.27	BSC	0.05 BSC		
L	0.05	0.25	0.002	0.010	
L1	0.325	0.525	0.013	0.021	
L2	0.500	0.800	0.020	0.031	
i	—	0.20	_	0.008	
К	0.61	0.91	0.024	0.036	
K1	0.31	0.60	0.012	0.024	
j	0.1015	i BSC	0.004	4BSC	

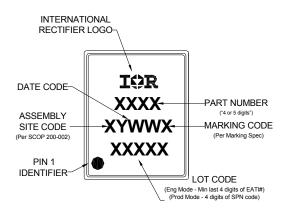
For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: <u>http://www.irf.com/technical-info/appnotes/an-1136.pdf</u> For more information on package inspection techniques, please refer to application note AN-1154:

L2-

http://www.irf.com/technical-info/appnotes/an-1154.pdf

## **Dual PQFN 5x6 Part Marking**

Plated Area



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

## **Qualification Information<sup>†</sup>**

		Automotive (per AEC-Q101)			
Qualificatio		Comments: This part number(s) passed Automotive qualification. IR's dustrial and Consumer qualification level is granted by extension of the hi er Automotive level.			
Moisture Sensitivity Level		Dual PQFN 5mm x 6mm	MSL1		
	Human Body Model	Class H1A (+/- 500V) <sup>††</sup>			
		AEC-Q101-001			
ESD	Charged Device Model		Class C5 (+/- 1000V) <sup>††</sup>		
		AEC-Q101-005			
RoHS Compliant		Yes			

† Qualification standards can be found at International Rectifier's web site: <u>http://www.irf.com/</u>

**††** Highest passing voltage.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- <sup>(2)</sup> Limited by  $T_{Jmax}$ , starting  $T_J = 25^{\circ}$ C, L =110µH,  $R_G = 50\Omega$ ,  $I_{AS} = 50A$ ,  $V_{GS} = 10V$ .
- $\label{eq:ISD} \ensuremath{\mathbb{S}} I_{SD} \leq 50A, \ensuremath{\,di/dt} \leq 650A/\mu s, \ensuremath{\,V_{\text{DD}}} \leq V_{(BR)DSS}, \ensuremath{\,T_{\text{J}}} \leq 175^\circ C.$
- ④ Pulse width  $\leq$  400µs; duty cycle  $\leq$  2%.
- (S) C<sub>oss eff. (TR)</sub> is a fixed capacitance that gives the same charging time as Coss while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © C<sub>oss eff. (ER)</sub> is a fixed capacitance that gives the same energy as Coss while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994: <u>http://www.irf.com/technical-info/appnotes/an-994.pdf</u>
- $\otimes$  R<sub> $\theta$ </sub> is measured at T<sub>J</sub> of approximately 90°C.
- (9) This value determined from sample failure population, starting  $T_J = 25^{\circ}$ C, L= 110µH, R<sub>G</sub> = 50Ω, I<sub>AS</sub> = 50A, V<sub>GS</sub> = 10V.

#### **IMPORTANT NOTICE**

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

IR warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with IR's standard warranty. Testing and other quality control techniques are used to the extent IR deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

IR assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using IR components. To minimize the risks with customer products and applications, customers should provide adequate design and operating safeguards.

Reproduction of IR information in IR data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alterations is an unfair and deceptive business practice. IR is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of IR products or serviced with statements different from or beyond the parameters stated by IR for that product or service voids all express and any implied warranties for the associated IR product or service and is an unfair and deceptive business practice. IR is not responsible or liable for any such statements.

IR products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of the IR product could create a situation where personal injury or death may occur. Should Buyer purchase or use IR products for any such unintended or unauthorized application, Buyer shall indemnify and hold International Rectifier and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that IR was negligent regarding the design or manufacture of the product.

Only products certified as military grade by the Defense Logistics Agency (DLA) of the US Department of Defense, are designed and manufactured to meet DLA military specifications required by certain military, aerospace or other applications. Buyers acknowledge and agree that any use of IR products not certified by DLA as military-grade, in applications requiring military grade products, is solely at the Buyer's own risk and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

IR products are neither designed nor intended for use in automotive applications or environments unless the specific IR products are designated by IR as compliant with ISO/TS 16949 requirements and bear a part number including the designation "AU". Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, IR will not be responsible for any failure to meet such requirements.

For technical support, please contact IR's Technical Assistance Center

http://www.irf.com/technical-info/

### WORLD HEADQUARTERS:

101 N. Sepulveda Blvd., El Segundo, California 90245

Tel: (310) 252-7105



单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)